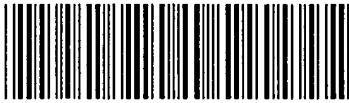


**Search Notes**

Application/Control No.

10/756,051

Examiner

Long K. Tran

Applicant(s)/Patent under  
Reexamination

JENG, ERIK S.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
N/A			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
257/314-321,390 (text search only, see search history printout)	12/2/2005	LKT
257/275-278, E21.662,E21.666 - E21.678 (text search only, see search history printout)	12/7/2005	LKT
Interference Search History Printout	12/7/2005	LKT